

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/659,808	BAUER ET AL.	
Examiner	Art Unit	
LOHA BEN	2873	Page 1 of 2

	SEAR	CHED	
Class	Subclass	Date	Examiner
359	245	5/5/2005	LB
	265		
	266		
	273		
	275		
	279		
	234		
	565		
	601		
	604		
	654		
	885		
	887	.	
	888	V	V

INT	ERFER	RENC	E SE	ARCH	IED	
Class	Subcla	ass	D	ate	Exam	niner
359	245	;	5/6/	2005	LI	В
	265	5	1			
	273	3				
	V	5				
	2	9				
	56	5				
	65	4				
atent and Trac	emark C	uffice.	,	1/		W

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST: Copies were attached to paper # 0804	8/5/2004	LB
WEST: Copies were attached to paper # 1204	12/14/2004	LB
WEST: Copies are attached herewith	5/5/2005	LB

U.S. Patent and Trademark Office

Part of Paper No. 0505



Application/Control No.	Applicant(s)/F Reexamination	
10/659,808	BAUER ET A	۸L.
Examiner	Art Unit	
LOHA BEN	2873	Page 2 of 2

	SEAR	CHED	
Class	Subclass	Date	Examiner
250	208.1	5/5/2005	LB
	208.2		
	394		
349	65		
	88		
252	583	, , , , , ,	
348	342		-
	363		
	364		
396	96		
	106		
362	284	V	V

	INTERFERENCE SEARCHED			ED
	Class	Subclass	Date	Examiner
	250	208.1	5/6/2005	LB
		208.2		
	349	65		
	252	583		
	348	342		
		363		
	396	96		
U.S. P	atent and Trad	emark Office	V	1

(INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
		:	
		,	
	•		
	-		
,		[

Part of Paper No. 0505